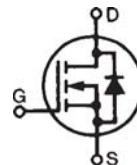


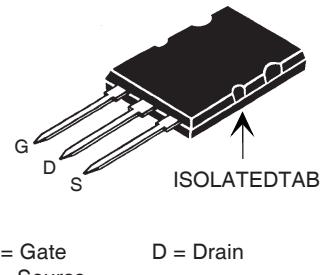
**HiPerFET™**  
**Power MOSFET**  
**Q2-Class**

**IXFL70N60Q2****(Electrically Isolated Tab)**

**V<sub>DSS</sub>** = 600V  
**I<sub>D25</sub>** = 37A  
**R<sub>DS(on)</sub>** ≤ 88mΩ  
**t<sub>rr</sub>** ≤ 250ns

N-Channel Enhancement Mode  
Avalanche Rated, Low Q<sub>G</sub>, Low Intrinsic R<sub>G</sub>  
High dV/dt, Low t<sub>rr</sub>

Symbol	Test Conditions	Maximum Ratings		
V <sub>DSS</sub>	T <sub>J</sub> = 25°C to 150°C	600		V
V <sub>DGR</sub>	T <sub>J</sub> = 25°C to 150°C, R <sub>GS</sub> = 1MΩ	600		V
V <sub>GSS</sub>	Continuous	± 30		V
V <sub>GSM</sub>	Transient	± 40		V
I <sub>D25</sub>	T <sub>C</sub> = 25°C	37		A
I <sub>DM</sub>	T <sub>C</sub> = 25°C, pulse width limited by T <sub>JM</sub>	280		A
I <sub>A</sub>	T <sub>C</sub> = 25°C	35		A
E <sub>AS</sub>	T <sub>C</sub> = 25°C	5		J
dV/dt	I <sub>S</sub> ≤ I <sub>DM</sub> , V <sub>DD</sub> ≤ V <sub>DSS</sub> , T <sub>J</sub> ≤ 150°C	20		V/ns
P <sub>D</sub>	T <sub>C</sub> = 25°C	360		W
T <sub>J</sub>		-55 ... +150		°C
T <sub>JM</sub>		150		°C
T <sub>stg</sub>		-55 ... +150		°C
T <sub>L</sub>	1.6 mm (0.063 in.) from case for 10s	300		°C
T <sub>SOLD</sub>	Plastic body for 10s	260		°C
F <sub>c</sub>	Mounting force	40..120 / 9..27		N/lbs
V <sub>ISOL</sub>	50/60 Hz, RMS t = 1 min	2500		V~
	I <sub>ISOL</sub> ≤ 1 mA t = 1 s	3000		V~
<b>Weight</b>		10		g

**ISOPLUS264**

G = Gate      D = Drain  
S = Source

**Features**

- Silicon chip on Direct-Copper Bond (DCB) substrate
- Isolated mounting surface
- 2500V electrical isolation
- Fast intrinsic diode
- Avalanche rated
- Low Q<sub>G</sub>
- Low package inductance

**Advantages**

- High power density
- Easy to mount
- Space savings

**Applications**

- DC-DC converters
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- Temperature and lighting controls

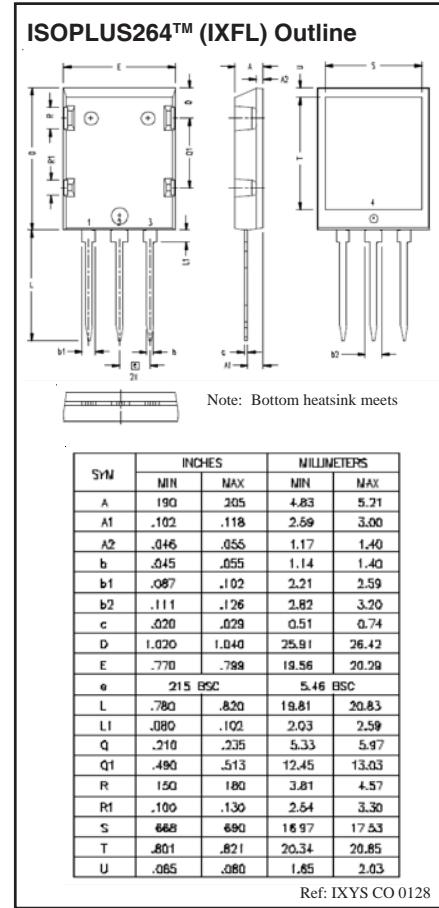
Symbol	Test Conditions	Characteristic Values		
		(T <sub>J</sub> = 25°C, unless otherwise specified)	Min.	Typ.
BV <sub>DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 1mA	600		V
V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 8mA	3.0		V
I <sub>GSS</sub>	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0V		± 200	nA
I <sub>DSS</sub>	V <sub>DS</sub> = V <sub>DSS</sub> V <sub>GS</sub> = 0V	T <sub>J</sub> = 125°C	100	μA
			5	mA
R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 35A, Note 1		88	mΩ

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$g_{fs}$	$V_{DS} = 10\text{V}$ , $I_D = 35\text{A}$ , Note 1	36	50	S
$C_{iss}$ $C_{oss}$ $C_{rss}$	$V_{GS} = 0\text{V}$ , $V_{DS} = 25\text{V}$ , $f = 1\text{MHz}$	12	nF	
		1340	pF	
		345	pF	
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	<b>Resistive Switching Times</b> $V_{GS} = 10\text{V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 35\text{A}$ $R_G = 1\Omega$ (External)	26	ns	
		25	ns	
		60	ns	
		12	ns	
$Q_{g(on)}$ $Q_{gs}$ $Q_{gd}$	$V_{GS} = 10\text{V}$ , $V_{DS} = 0.5 \cdot V_{DSS}$ , $I_D = 35\text{A}$	265	nC	
		57	nC	
		120	nC	
$R_{thJC}$			0.35	°C/W
$R_{thCS}$		0.15		°C/W

### Source-Drain Diode

Symbol	Test Conditions ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)	Characteristic Values		
		Min.	Typ.	Max.
$I_s$	$V_{GS} = 0\text{V}$		70	A
$I_{SM}$	Repetitive, pulse width limited by $T_{JM}$		280	A
$V_{SD}$	$I_F = I_S$ , $V_{GS} = 0\text{V}$ , Note 1		1.5	V
$t_{rr}$ $Q_{RM}$ $I_{RM}$	$I_F = 25\text{A}$ , $V_{GS} = 0\text{V}$ -di/dt = 100 A/μs $V_R = 100\text{ V}$		250	ns
		1.2		μC
		8.0		A

Note: 1. Pulse test,  $t \leq 300\mu\text{s}$ , duty cycle,  $d \leq 2\%$ .



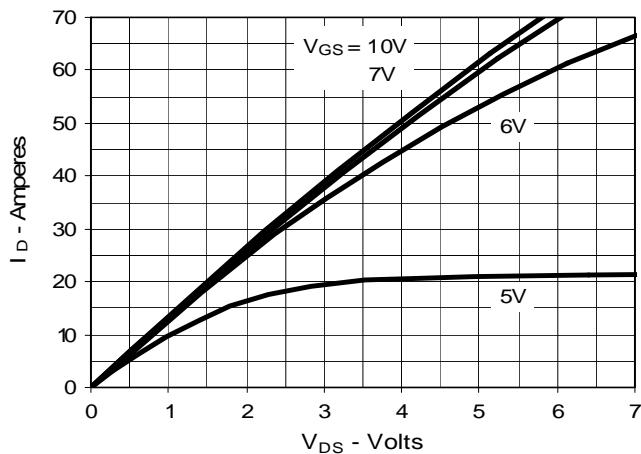
### PRELIMINARY TECHNICAL INFORMATION

The product presented herein is under development. The Technical Specifications offered are derived from data gathered during objective characterizations of preliminary engineering lots; but also may yet contain some information supplied during a pre-production design evaluation. IXYS reserves the right to change limits, test conditions, and dimensions without notice.

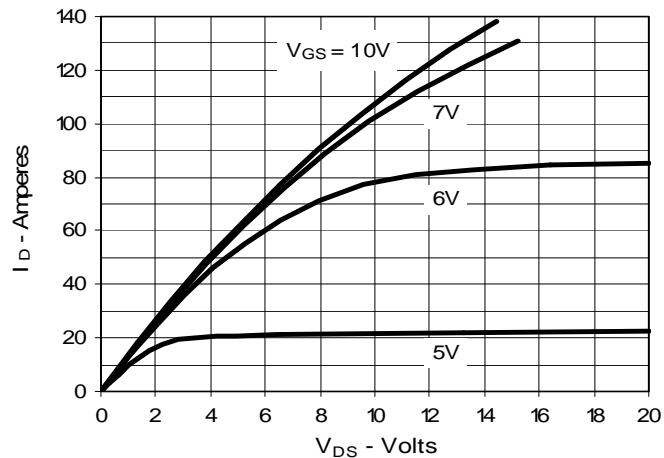
IXYS reserves the right to change limits, test conditions, and dimensions.

IXYS MOSFETs and IGBTs are covered by one or more of the following U.S. patents: 4,835,592 4,931,844 5,049,961 5,237,481 6,162,665 6,404,065 B1 6,683,344 6,727,585 7,005,734 B2 7,157,338B2 4,850,072 5,017,508 5,063,307 5,381,025 6,259,123 B1 6,534,343 6,710,405 B2 6,759,692 7,063,975 B2 4,881,106 5,034,796 5,187,117 5,486,715 6,306,728 B1 6,583,505 6,710,463 6,771,478 B2 7,071,537

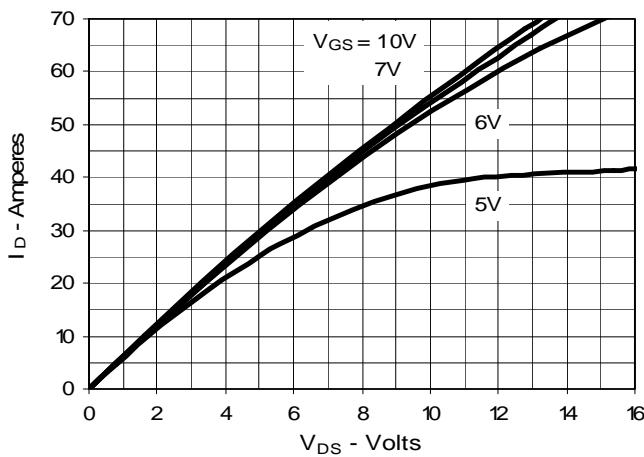
**Fig. 1. Output Characteristics  
@ 25°C**



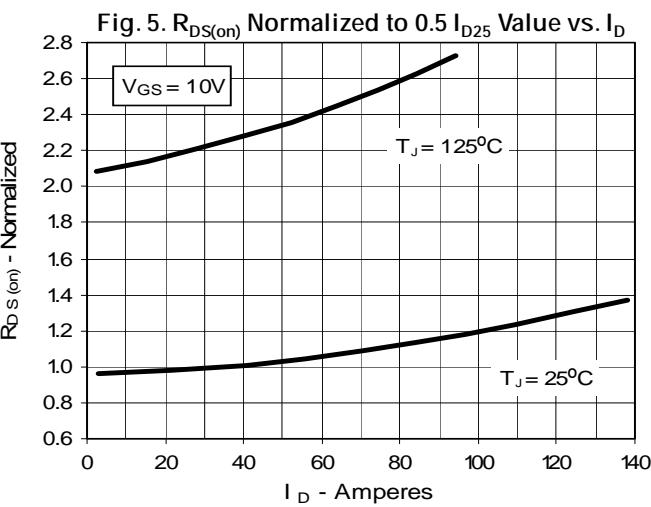
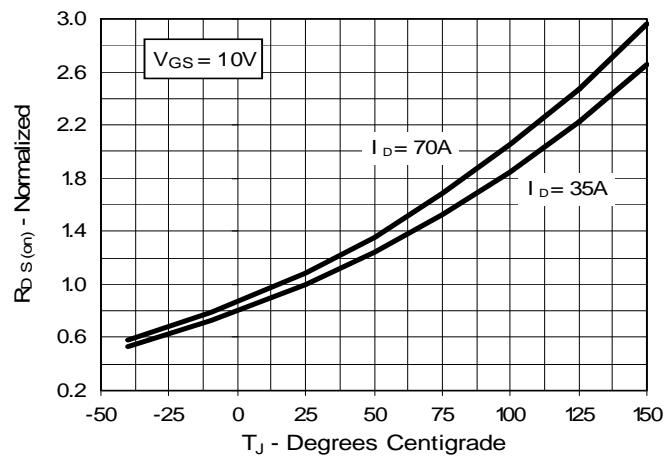
**Fig. 2. Extended Output Characteristics  
@ 25°C**



**Fig. 3. Output Characteristics  
@ 125°C**



**Fig. 4.  $R_{DS(on)}$  Normalized to 0.5  $I_{D25}$  Value vs.  
Junction Temperature**



**Fig. 6. Drain Current vs. Case Temperature**

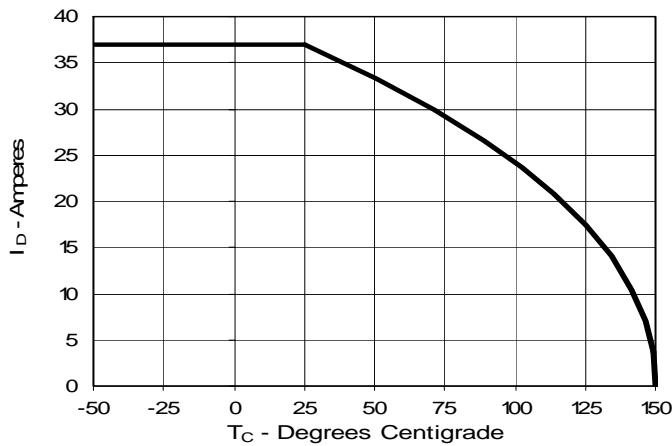


Fig. 7. Input Admittance

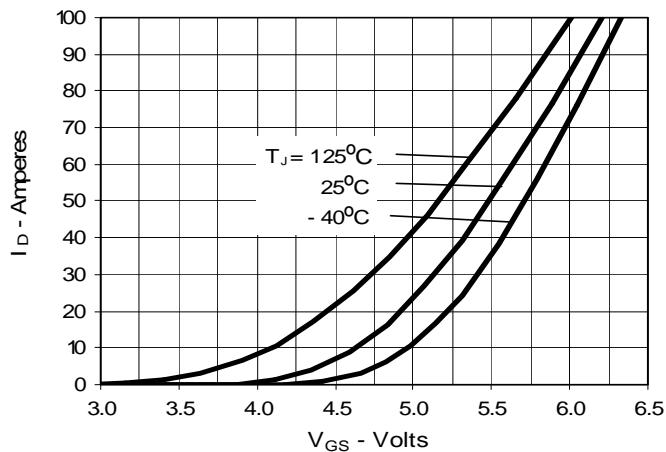


Fig. 8. Transconductance

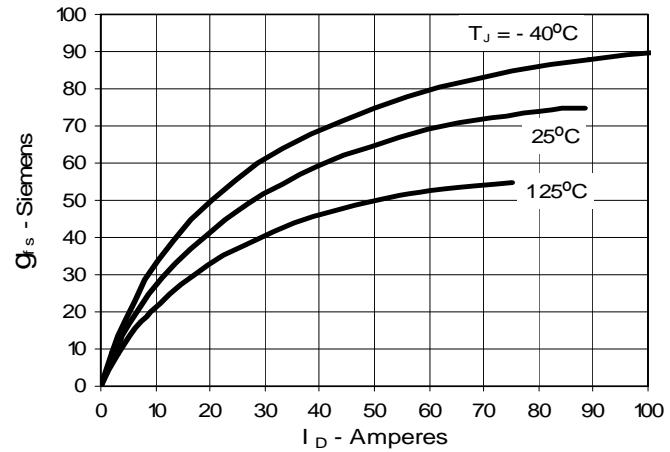


Fig. 9. Source Current vs. Source-To-Drain Voltage

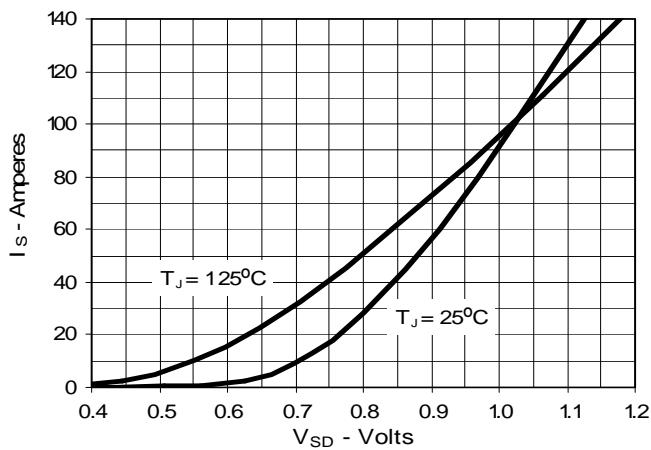


Fig. 10. Gate Charge

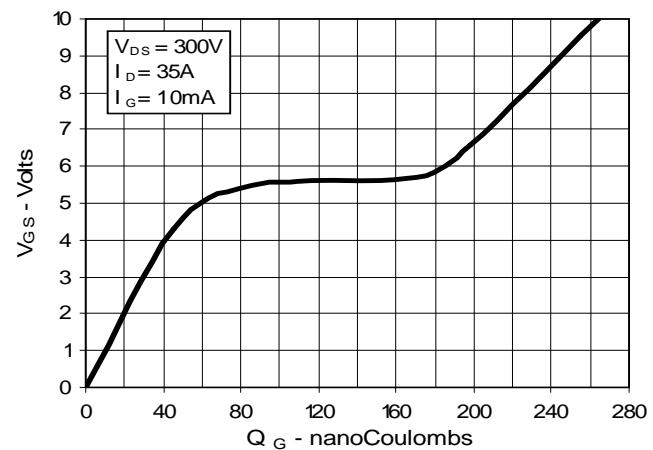


Fig. 11. Capacitance

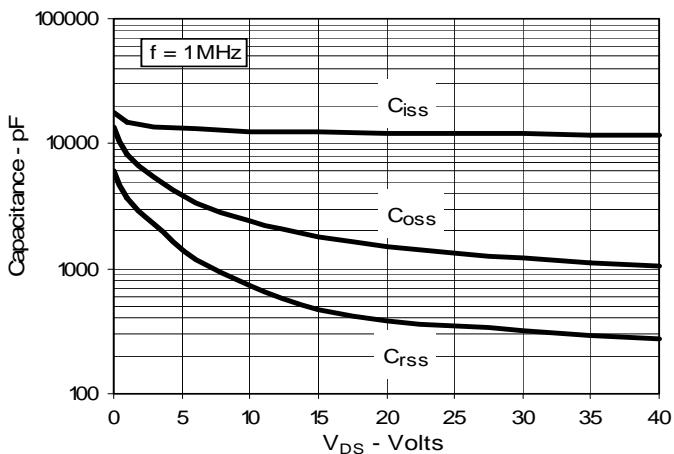


Fig. 12. Maximum Transient Thermal Impedance

